Se	arcn Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/618,857	KIM ET AL.	
Examiner	Art Unit	
Kathleen S. Yuan	2624	

	SEAR	CHED	
Class	Subclass	Date	Examiner
382	115	6/1/2007	кү
			
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST searchlimited by text	6/1/2007	кү